

Notice of References Cited	Application/Control No. 10/660,055	Applicant(s)/Patent Under Reexamination KNEE ET AL.	
	Examiner Sargon N. Nano	Art Unit 2157	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,665,725	12-2003	Dietz et al.	709/230
*	B	US-2002/0016843	02-2002	Schweitzer et al.	709/227
*	C	US-2003/0177252	09-2003	Krichevski et al.	709/230
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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	P					
	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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